

<u>PART NO.</u> MVR0603-5R5E330

1. Electrical Specification

1-1 Test condition

Varistor voltage	In = 1 mA DC
Leakage current	Vdc = 5.5 V DC
Maximum clamping voltage	lc = 1 A
Rated peak single pulse transient current	8 / 20 μ s waveform, +/- each 1 time induce
Capacitance	10/1000 µs waveform
Insulation resistance after reflow soldering	f = 1MHz, Vrms = 0.5 V
Reflow soldering condition	Soldering paste : Tamura (Japan) RMA-20-21L Stencil : SUS, 120 µm thickness Pad size : 0.8 (Width) x 0.9 (Length) 0.8 (Distance between pads) Soldering profile : 260±5 °C, 5 sec.

1-2 Electrical specification

Maximum allowable continuous DC voltage	5.5	V	
trigger voltage / Varistor voltage / breakdown voltage	7.6-12	V	
Maximum clamping voltage	45	V	Maximum
Rated peak single pulse transient current	1	А	Maximum
Nonlinearity coefficient	> 12		
Leakage current at continuous DC voltage	< 0.1	μA	
Response time	< 0.5	ns	
Varistor voltage temperature coefficient	< 0.05	%/℃	
Capacitance measured at 1MHz	33	pF	Typical
Capacitance tolerance	-50 to +80	%	
Insulation resistance after reflow soldering on PCB	> 10	MΩ	
Operating ambient temperature	-55 to +125	°C	
Storage temperature	-55 to +125	$^{\circ}\!\mathrm{C}$	

TCR MULTILAYER CHIP VARISTORS

1-3 Reliability testing procedures

Reliability parameter	Test	Test methods and remarks	Test requirement
Pulse current	Imax	IEC 1051-1, Test 4.5.	d $ Vn /Vn \le 10\%$
capability	8/20 μs	10 pulses in the same direction at 2 pulses per minute at maximum peak current	no visible damage
Electrostatic discharge capability	ESD C=150 pF, R=330 Ω	<u>IEC 1000-4-2</u> Each 10 times in positive/negative direction in 10 sec at 8KV contact discharge (Level 4)	d Vn /Vn ≤ 10% no visible damage
Environmenta I reliability	Thermal shock	<u>IEC 68-2-14</u> Condition for 1 cycle Step 1 : Min40℃, 30±3 min. Step 2 : Max. +125℃, 30±3 min. Number of cycles: 30 times	d Vn /Vn ≤5% no visible damage
	Low temperature	$\frac{\text{IEC 68-2-1}}{\text{Place the chip at } -40\pm5^{\circ}\text{C} \text{ for } 1000\pm12\text{hrs. Remove and place for } 24\pm2\text{hrs at room temp. condition, then measure}}$	d Vn /Vn≤5% no visible damage
	High temperature	<u>IEC 68-2-2</u> Place the chip at $125\pm5^{\circ}$ °C for $1000\pm$ 24hrs. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	d Vn /Vn≤5% no visible damage
	Heat resistance	<u>IEC 68-2-3</u> Apply the rated voltage for 1000 ± 48 hrs at 85 ± 3 °C. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	d Vn /Vn ≤ 5% no visible damage
	Humidity resistance	<u>IEC 68-2-30</u> Place the chip at $40\pm2^{\circ}$ C and 90 to 95% humidity for 1000 ± 24 hrs. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	d│Vn│/Vn≤10% no visible damage
	Pressure cooker test	Place the chip at 2 atm, $120^{\circ}C$, 85% RH for 60 hrs. Remove and place for $24 \pm$ 2hrs at room temp. condition, then measure	d Vn /Vn≤10% no visible damage
	Operating life	Apply the rated voltage for 1000±48hrs at 125±3℃. Remove and place for 24± 2hrs at room temp. condition, then measure	d Vn /Vn≤10% no visible damage

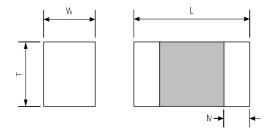
TCR MULTILAYER CHIP VARISTORS

Mechanical Reliability	Solderability	<u>IEC 68-2-58</u> Solder bath method, 230±5℃, 2s	At least 95% of terminal electrode is covered by new solder
	Resistance to	IEC 68-2-58	d Vn /Vn≤5%
	soldering heat	Solder bath method, 260±5℃, 10±0.5s, 270±5℃, 3±0.5s	no visible damage
	Bending strength	IEC 68-2-21	d Vn /Vn≤5%
		Warp:2mm, Speed:0.5mm/sec, Duration: 10sec. The measurement shall be made with board in the bent position	no visible damage
	Adhesive strength	IEC 68-2-22	Strength>10 N
		Applied force on SMD chip by fracture from PCB	no visible damage

2. Material Specification

Body	ZnO based ceramics
Internal electrode	Silver – Palladium
External electrode	Silver – Nickel – Tin
Thickness of Ni/Sn plating layer	Nickel > 1 μ m, Tin > 2 μ m

3. Dimension Specification



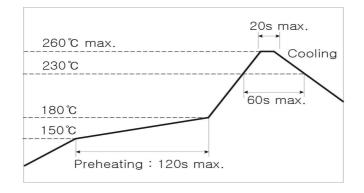
Size	L(mm)	W(mm)	⊤(mm)	M(mm)
0402	1.0 ± 0.10	0.5 ± 0.10	≤ 0.6	0.20 ± 0.10
0603	1.6 ± 0.15	0.8 ± 0.15	≤ 0.9	0.35 ± 0.10

4. Soldering Recommendations

4-1 Soldering profile

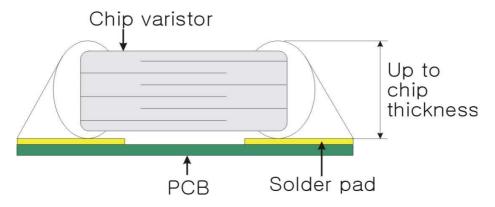


4-1-1 Pb free solder paste



4-1-2 Repair soldering

- Allowable time and temperature for making correction with a soldering iron : 350 $\,\pm\,$ 10 $\,^\circ\!\mathrm{C}$, 3 sec.
- Optimum solder amount when corrections are made using a soldering iron

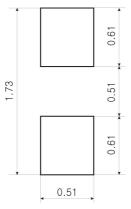


4-2 Soldering guidelines

- Our chip varistors are designed for reflow soldering only. Do not use flow soldering
- Use non-activated flux (CI content 0.2% max.)
- Follow the recommended soldering conditions to avoid varistor damage.



4-3 Solder pad layout



5. Storage condition

- Storage environment must be at an ambient temperature of 25~35 $\,^\circ\!\!\mathbb{C}\,$ and an ambient humidity of 40~60 % RH
- Chip varistors can experience degradation of termination solderability when subjected to high temperature of humidity, or if exposed to sulfur or chlorine gases.
- Avoid mechanical shock (ex. Falling) to the chip varistor to prevent mechanical cracking inside of the ceramic dielectric due to its own weight.
- Use chips within 6 months.

If 6 months of more have elapsed, check solderability before use.-

6. Description about package label

Type : MVR0603-5R5E330

MVR: Series name 0603 : Chip size –0603 (1.6 x 0.8 mm) size 5R5 : Maximum continuous working voltage – 5.5Vdc E : Product function – E for ESD 330 : Capacitance value – means 33 pF

Qunatity : 4,000 pcs

- Quantity of shipping chip varistor